

# 6AM12

## Silicon N Channel/P Channel Complementary Power MOS FET Array

### Application

High speed power switching

### Features

- Low on-resistance  
 N-channel:  $R_{DS(on)} \leq 0.17 \Omega$ ,  $V_{GS} = 10 \text{ V}$   
 $I_D = 4 \text{ A}$   
 P-channel:  $R_{DS(on)} \leq 0.2 \Omega$ ,  $V_{GS} = -10 \text{ V}$   
 $I_D = -4 \text{ A}$
- Capable of 4 V gate drive
- Low drive current
- High speed switching
- High density mounting
- Suitable for H-bridged motor driver
- Discrete packaged devices of same die  
 N-channel: 2SK970 (TO-220AB),  
 2SK1093 (TO-220FM)  
 P-channel: 2SJ172 (TO-220AB),  
 2SJ175 (TO-220FM)

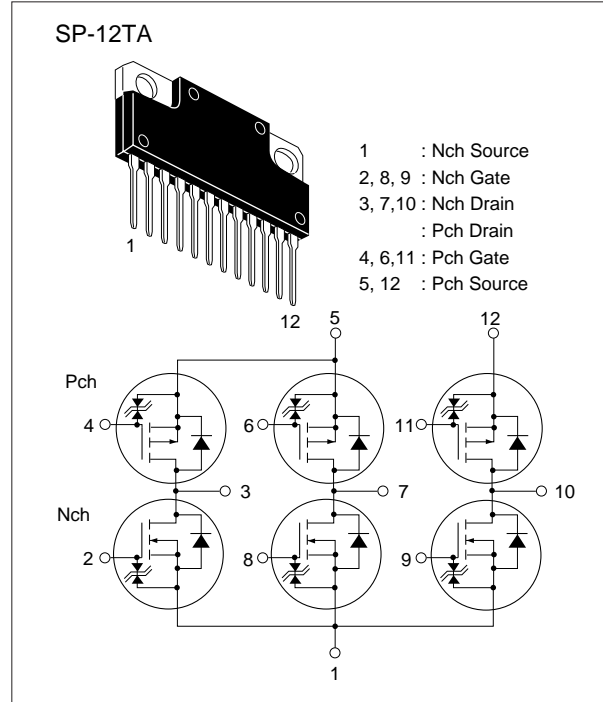


Table 1 Absolute Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

Item	Symbol	Ratings		
		Nch	Pch	Unit
Drain to source voltage	$V_{DSS}$	60	-60	V
Gate to source voltage	$V_{GSS}$	$\pm 20$	$\pm 20$	V
Drain current	$I_D$	7	-7	A
Drain peak current	$I_{D(pulse)}^*$	28	-28	A
Body-drain diode reverse drain current	$I_{DR}$	7	-7	A
Channel dissipation	Pch ( $T_c = 25^\circ\text{C}$ )**	42		W
Channel dissipation	Pch**	4.8		W
Channel temperature	$T_{ch}$	150		$^\circ\text{C}$
Storage temperature	$T_{stg}$	-55 to +150		$^\circ\text{C}$

\*  $PW \leq 10 \mu\text{s}$ , duty cycle  $\leq 1 \%$

\*\* 6 devices operation

**Table 2 Electrical Characteristics** (Ta = 25°C) (1 Unit)

Item	Symbol	N channel			P channel			Unit	Test Conditions
		Min	Typ	Max	Min	Typ	Max		
Drain to source breakdown voltage	$V_{(BR)DSS}$	60	—	—	-60	—	—	V	$I_D = 10 \text{ mA}, V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	$\pm 20$	—	—	$\pm 20$	—	—	V	$I_G = \pm 100 \text{ }\mu\text{A}, V_{DS} = 0$
Gate to source leak current	$I_{GSS}$	—	—	$\pm 10$	—	—	$\pm 10$	$\mu\text{A}$	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0$
Zero gate voltage drain current	$I_{DSS}$	—	—	250	—	—	-250	$\mu\text{A}$	$V_{DS} = 50 \text{ V}, V_{GS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	1.0	—	2.0	-1.0	—	-2.0	V	$I_D = 1 \text{ mA}, V_{DS} = 10 \text{ V}$
Static drain to source on state resistance	$R_{DS(on)}$	—	0.13	0.17	—	0.15	0.2	$\Omega$	$I_D = 4 \text{ A}, V_{GS} = 10 \text{ V}^*$
		—	0.19	0.24	—	0.20	0.27	$\Omega$	$I_D = 4 \text{ A}, V_{GS} = 4 \text{ V}^*$
Forward transfer admittance	$ y_{fs} $	3.5	5.5	—	3.5	6.0	—	S	$I_D = 4 \text{ A} * V_{DS} = 10 \text{ V}^*$
Input capacitance	$C_{iss}$	—	400	—	—	900	—	pF	$V_{DS} = 10 \text{ V}, V_{GS} = 0$ $f = 1 \text{ MHz}$
Output capacitance	$C_{oss}$	—	220	—	—	460	—	pF	
Reverse transfer capacitance	$C_{rss}$	—	60	—	—	130	—	pF	
Turn-on delay time	$t_{d(on)}$	—	5	—	—	8	—	ns	$I_D = 4 \text{ A}, V_{GS} = 10 \text{ V},$ $R_L = 7.5 \text{ }\Omega$
Rise time	$t_r$	—	45	—	—	50	—	ns	
Turn-off delay time	$t_{d(off)}$	—	150	—	—	170	—	ns	
Fall time	$t_f$	—	80	—	—	95	—	ns	
Body-drain diode forward voltage	$V_{DF}$	—	1.1	—	—	-1.05	—	V	$I_F = 7 \text{ A}, V_{GS} = 0$
Body-drain diode reverse recovery time	$t_{rr}$	—	110	—	—	180	—	ns	$I_F = 7 \text{ A}, V_{GS} = 0,$ $di_F/dt = 50 \text{ A}/\mu\text{s}$

Note: Polarity of test conditions for P channel device is reversed.

\* Pulse Test

■ Nch : See characteristic curves of 2SK970

■ Pch : See characteristic curves of 2SJ172

